Notice of References Cited Application/Control No. 10/549,451 Examiner PHUC TRAN Applicant(s)/Patent Under Reexamination HAYASHI, KENJI Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | Α | US-6,606,015 | 08-2003 | Uriu et al. | 333/132 |
| * | В | US-6,768,898 | 07-2004 | Furutani et al. | 455/82 |
| * | С | US-6,975,841 | 12-2005 | Uriu et al. | 455/78 |
| * | D | US-7,057,472 | 06-2006 | Fukamachi et al. | 333/101 |
| | Е | US- | | | |
| | F | US- | | | |
| | O | US- | | | |
| | Ι | US- | | 1 | |
| | _ | US- | | | |
| | 7 | US- | | | |
| | K | US- | 1 | | |
| | Ш | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| 6 | R | | | | | |
| | s | | | | | |
| | - | | | | 100 | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | w | |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.